



Attorney's Docket No.: 12732-038001 / US4917/4945

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hideomi Suzawa et al. Art Unit : 2812
Serial No. : 09/852,672 Examiner : Alexander G. Ghyska
Filed : May 11, 2001 Confirmation No.: 5083
Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

MAIL STOP RCE
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

Submitted herewith is an English translation of the following foreign language references, or portions thereof:

Desig. ID	Source
ABBB	JAPAN 01-207973 – English Abstract: DIALOG® FILE 352:Derwent WPI (2001); Accession No. 008017742
ACCC	JAPAN 07-130652 – English Abstract: DIALOG® FILE 347:JAPIO (1998); Accession No. 04838052
ADDD	JAPAN 09-054318 – Full English language translation
AEEE	JAPAN 10-048640 – English Abstract: 1998, 2003 JAPAN PATENT OFFICE©
AFFF	JAPAN 10-073813 – English Abstract: DIALOG® FILE 347:JAPIO (2002); Accession No. 05790713
AGGG	JAPAN 10-326772 – English Abstract: DIALOG® FILE 352:Derwent WPI (2001); Accession No. 012285689
AHHH	JAPAN 11-258596 – English Abstract: DIALOG® FILE 352:Derwent WPI (2000); Accession No. 012788624
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AJJJ	JAPAN 2001-085700 – English Abstract: esp@cenet database – Worldwide (2005): http://v3.espacenet.com/textdoc?DB=EPODOC&IDX=JP2001085700&F=8&QPN=...

Alex Ghyska 7/16/06

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 12732-038001	Application No. 09/852,672
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hideomi Suzawa et al.			
		Filing Date May 11, 2001	Group Art Unit 2812		

O P E R A T I O N S
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Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-038001	Application No. 09/852,672
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hideomi Suzawa et al.	JUN 13 2005 PATENT & TRADEMARK OFFICE U.S. DEPARTMENT OF COMMERCE
		Filing Date May 11, 2001	

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Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No
<i>AC</i>	AZZ	0 680 079 A2	11/02/1995	EUROPE			In English
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	AHHH	11-258596	09/24/1999	JAPAN			ABS
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	AP						

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	AQ	
	AR	
	AS	
	AT	

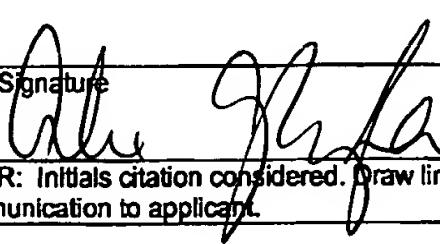
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Foreign Patent Documents or Published Foreign Patent Applications							
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